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Benzoquinoline-based fluoranthene derivatives as electron transport materials for solution-processed red phosphorescent organic light-emitting diodes†

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A new electron transport material (ETM) with two fluoranthene and a benzoquinoline moiety was synthesized for the fabrication of solution-processed phosphorescent organic light-emitting diodes (PHOLEDs). In particular, we designed a bulky structure with a large twisted angle and improved thermal stability as compared to those of the common ETMs [e.g., 2,2',2''-(1,3,5-phenylene)tris(1-phenyl-1*H*-benzimidazole) (TPBI)] for device stability. As a result, we found that 4-(3-(fluoranthene-3-yl)-5-(fluoranthene-4-yl)phenyl)-2-phenyl-benzo[*h*]quinoline (FRT-PBQ) showed high glass transition temperature (T_g : ~ 184 °C) and moderately high electron transport behavior despite its bulky structural moieties. Moreover, we fabricated solution-processed red PHOLEDs with FRT-PBQ, and a relatively high current efficiency and external quantum efficiency of up to 20.7 cd A⁻¹ and 15.5%, respectively, were achieved. In addition, the device lifetime was extended by a factor of 1.7 as compared to that of the device fabricated with TPBI as a common ETM.

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Introduction

Active matrix organic light-emitting diodes (AMOLEDs) have received significant attention because of their advantages such as their ability to fabricate large-area displays and solid-state lighting. It is very difficult to manufacture large-area and high-resolution AMOLEDs as their production is based on the thermal vacuum deposition method, which results in a high manufacturing cost of mass production due to significant organic material consumption during deposition. Thus, to reduce the manufacturing cost, many research groups have focused on solution processes such as spin-coating, nozzle printing, and ink-jet printing.^{1–6} Due to these efforts, the efficiency of the devices has reached values similar to those achieved with vacuum deposition, but the lifetime of the devices is still considerably shorter.⁷ Thus, solution-processed OLEDs should be further developed to reach a level suitable for commercialization.

The most important issue to obtain highly efficient solution-processed OLEDs is to realize multi-layer deposition without any mixing of each layer. In other words, it is important to have perfect orthogonality for each functional layer (e.g., hole

transport layer (HTL) and emitting layer (EML)).^{7,8} To achieve orthogonal solubility, polymer-based cross-linkable materials have been used as HTLs for solution-processed OLEDs.^{1,2,9,10} However, cross-linkable HTLs mostly restrict the hole flow because of the lower hole mobility [μ_{hole} (cross-linkable HTL) $\approx 10^{-6}$ cm² V⁻¹ s⁻¹] as compared to that of the commonly used HTL materials.^{1,2,11} As a result, the recombination zone of the solution-processed OLEDs should be shifted towards the HTL/EML interface although it could be the main reason for the deterioration of device lifetime as well as the induced exciton quenching.^{1,2} To solve this problem, we need to control the charge balance of the devices using various materials for EMLs and electron transport layers (ETLs).^{12–17} In this study, we focused on new electron transport materials (ETMs) for solution-processed OLEDs because the common ETMs normally exhibited very low glass transition temperature (TPBI = 124 °C), which resulted in a reduced device lifetime because of molecular crystallization from joule-heating of the devices.¹⁸ In other words, we report a new ETM with pretty high glass transition temperature (T_g) (about 184 °C) as well as moderately higher electron transport behavior than those of the reported previously ETMs [e.g. TPBI (2,2',2''-(1,3,5-phenylene)tris(1-phenyl-1*H*-benzimidazole)), BPhen (4,7-diphenyl-1,10-phenanthro-line) Alq₃ (tris-(8-hydroxyquinoline) aluminum), etc.]. As a result, we obtained a moderately high device efficiency up to 20.7 cd A⁻¹ using 4-(3-(fluoranthene-3-yl)-5-(fluoranthene-4-yl)phenyl)-2-phenyl-benzo[*h*]quinoline (FRT-PBQ).

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Experimental

Instruments

^1H NMR spectra were obtained using a Bruker AVANCE II 400 MHz NMR spectrometer. The absorption spectrum was obtained using a ultraviolet-visible (UV-vis) spectrophotometer (UV-1650PC). Photoluminescence (PL) spectra were acquired using a Perkin Elmer photoluminescence spectrophotometer (LS 55 model). Thermogravimetric analysis (TGA) was performed using TA INSTRUMENT TA4100. Differential scanning calorimetry (DSC) was performed using a Perkin Elmer model DSC-N650, operated under a nitrogen atmosphere. Matrix-assisted laser desorption/ionization time-of-flight mass spectrometry (MALDI-TOF MS) experiments were performed *via* a Bruker Daltonics model Ultraflex III MALDI TOF/TOF. High performance liquid chromatography (HPLC) was performed using a Waters model 2695 HPLC system. The positions of the highest occupied molecular orbital (HOMO) was measured using a photoelectron spectrometer (AC2, Riken Keiki). Carbon, hydrogen, and nitrogen analyses were conducted using an elemental analyzer (Flash1112/Flash2000, CE Instrument, Italy).

Materials

The following materials were either purchased or synthesized. Poly(3,4-ethylene dioxathiophene) (PEDOT) doped with poly(styrenesulfonate) anions (PSS) (PEDOT:PSS) was purchased from Heraeus (Heraeus Clevios™ P VP CH 8000) as a hole injection layer (HIL) and HL-X026, a cross-linkable material (XM , T_1 : 2.25 eV), was purchased from Merck as an HTL.^{1,2,19,20} 11-[2'-Diphenyl-[1,3,5]triazin-2-yl]-biphenyl-4-yl]-11*H*-benzo[*a*]carbazole as a red host material (RH, TRZ-PBC) was purchased from KISCO and iridium(III) bis(2-(3,5-dimethylphenyl)quinolinato-*N*,*C*2')tetra-methylheptadionate, Ir(mphq)₂tmd (Red Dopant, RD) was purchased from Lumtec and used as a phosphorescent red dopant for EML.^{1,2,21} In addition, **FRT-PBQ** was synthesized and used as a material for ETL. 2,2',2''-(1,3,5-Phenylene)tris(1-phenyl-1*H*-benzimidazole) (TPBI) as an ETL, lithium fluoride (LiF) as a material for an electron injection layer (EIL), and aluminum (Al) as a cathode were also purchased from commercial suppliers and used without purification.

Materials synthesis of a new electron transport material

FRT-PBQ (A): (*E*)-2-(3,5-dibromobenzylidene)-3,4-dihydro-*naphthalen*-1(2*H*)-one. A mixture of 3,5-dibromobenzaldehyde (20.0 g, 75.8 mmol), α -tetralone (15.5 g, 106.1 mmol), and ethanol (400 ml) was added dropwise to a 8.5 M NaOH solution (in water) at 0 °C. The resulting mixture was stirred for 1 h and then filtered. The obtained solid was washed with water and ethanol to obtain the product. Yellowish powder (22.0 g, yield: 74%). ^1H -NMR (CDCl_3) δ [ppm]: 7.88 [s, 1H], 7.73 [d, 1H], 7.68 [t, 1H], 7.61 [s, 1H], 7.51 [s, 2H], 7.46–7.48 [m, 2H], 3.10–2.90 [m, 4H].

FRT-PBQ (B): 4-(3,5-dibromophenyl)-4a,5,6,10b-tetrahydro-2-phenylbenzo[*h*]quinoline. Pyridine (120.0 ml) was added dropwise to phenacyl bromide (12.0 g, 60.3 mmol) at room

temperature for 1 h. The resulting mixture was filtered and then washed with ethyl ether. The product was dried under vacuum and directly used for the next step. Then, a white powder was obtained (13.0 g, yield: 77.5%). The obtained solid (12.8 g, 45.9 mmol) was added dropwise to a solution of compound **FRT-PBQ (A)** (15.0 g, 38.3 mmol) and ammonium acetate (14.7 g, 191.3 mmol) in acetic acid (150 ml). The mixture was refluxed for 12 h after cooling down to room temperature. The resulting mixture was filtered and then washed with methanol. White powder (12.3 g, yield: 65.4%). ^1H -NMR (CDCl_3) δ [ppm]: 8.30 [d, 2H], 8.14 [d, 1H], 7.96 [s, 2H], 7.54 [t, 2H], 7.45–7.35 [m, 6H], 2.99 [s, 4H].

FRT-PBQ (C): 4-(3,5-dibromophenyl)-2-phenylbenzo[*h*]quinoline. A mixture of compound **FRT-PBQ (B)** (12.0 g, 24.4 mmol) and 2,3-dichloro-5,6-dicyano-*p*-benzoquinone (12.2 g, 53.7 mmol) in 1,4-dioxane (180 ml) was refluxed for 12 h. After being cooled down to room temperature, dichloromethane was added to the reaction mixture. The organic phase was separated and washed with brine before being dried over anhydrous MgSO_4 . The solvent was evaporated and the residue was purified by column chromatography on silica gel using dichloromethane/hexane. Ivory powder (8.10 g, yield: 67.8%). ^1H -NMR (CDCl_3) δ [ppm]: 8.51 [d, 1H], 8.30 [m, 2H], 8.16 [d, 1H], 8.06 [d, 1H], 7.92 [s, 1H], 7.81 [d, 1H], 7.70–7.60 [m, 3H], 7.55–7.40 [m, 5H].

FRT-PBQ: 4-(3-(fluoranthene-3-yl)-5-(fluoranthene-4-yl)phenyl)-2-phenylbenzo[*h*]quinoline. A mixture of compound **FRT-PBQ (C)** (15.0 g, 30.7 mmol), fluoranthene-3-yl-3-boronic acid (12.2 g, 53.7 mmol), $\text{Pd}(\text{pPh}_3)_4$ (1.06 g, 0.92 mmol), and 1 M K_2CO_3 (150 ml) in THF (300 ml) was refluxed for 12 h. After being cooled down to room temperature, the reaction mixture was extracted with dichloromethane and deionized water. The solvent was evaporated, and the residue was purified *via* column chromatography on silica gel using dichloromethane/hexane. White powder (13.4 g, yield: 60%). ^1H -NMR (CDCl_3) δ [ppm]: 9.59 [d, 1H], 8.40 [d, 2H], 8.16 [m, 3H], 8.12 [d, 1H], 8.04 [d, 3H], 7.94 [m, 9H], 7.85 [d, 3H], 7.78 [m, 4H], 7.68 [t, 2H], 7.54 [t, 1H], 7.40 [m, 4H]. MALDI-TOF MS: m/z 731.88, cal. 731.914. Anal. calc. for $\text{C}_{57}\text{H}_{33}\text{N}$: C, 93.54; H, 4.54; N, 1.91; found: C, 93.62; H, 4.55; N, 1.99.

Device fabrication

To fabricate OLED devices with solution-processed red PHOLEDs, a 150 nm-thick patterned indium–tin oxide (ITO) glass with an open emission area of 4 mm² was used. The ITO glass was cleaned in acetone and isopropyl alcohol *via* ultrasonication and rinsed in deionized water. Then, the ITO glasses were treated in UV-ozone to eliminate all the organic impurities that remained during the previous fabrication processes. PEDOT:PSS was spin-coated on an ITO glasses under ambient conditions and annealed at 150 °C for 15 min in a nitrogen atmosphere. Subsequently, the HTL material was dissolved in chlorobenzene at 0.5 wt% and spin-coated and cross-linked *via* the standard process. For the EML materials, the RH and red phosphorescent dopant (RD) were dissolved in toluene to obtain a 1 and 0.5 wt% solution. The red EML solution obtained



by mixing the host and dopant solutions was spin-coated and dried at 100 °C for 10 min in a glove box. Then, the ETL was thermally deposited at a rate of 0.5 \AA s^{-1} under typical vacuum conditions ($<10^{-7}$ Torr). After the completion of all the solution and evaporation processes of the organic species, LiF and Al were successively deposited at 0.3 \AA s^{-1} and 3 \AA s^{-1} , respectively.

Measurements

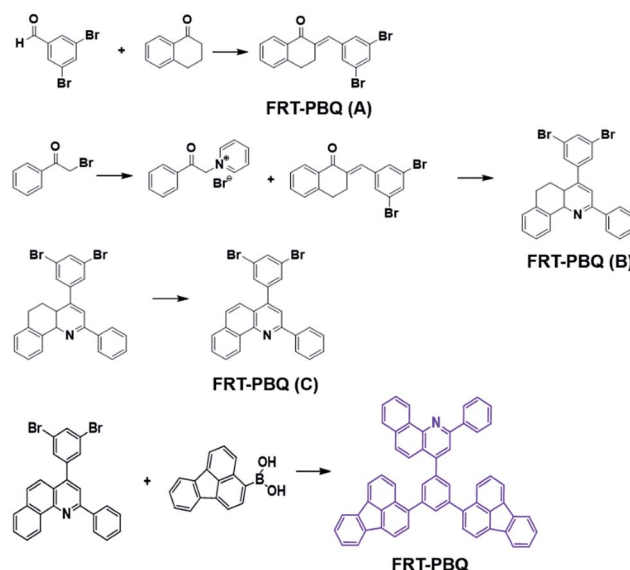
The current density–voltage (J – V) and luminance–voltage (L – V) data of OLEDs were obtained using a Keithley SMU 2635A and Minolta CS-100A, respectively. The OLED area was 4 mm^2 for all the samples studied in this work. Electroluminescence (EL) spectra and the Commission Internationale De'Eclairage (CIE) coordinates were obtained using a Minolta CS-2000A spectroradiometer.

Results and discussion

Basic properties of FRT-PBQ

As previously reported, the carrier mobility μ of the hole and/or electron transport materials can be influenced by the molecular geometry of these materials (*e.g.* twisted angle between shell moieties, size of the pendant groups, planarity of the molecules near the core moiety, *etc.*). Especially, the mobility significantly decreases if the carrier hopping is limited due to the molecular geometry of these materials.²² In other words, μ is seriously affected by the molecular structure, which can cause molecular stacking through π – π interaction. Thus, μ increases if the hopping charge interacts with randomly oriented and located dipoles in the bulk film. However, T_g increases with molecular size and molecular weight. In other words, it normally increases if the sizes of the pendant moieties are bigger because they limit the segmental motion of the molecule. Based on these aspects, we synthesized a new ETM with two large fluoranthene and a benzoquinoline moiety for solution-processed OLEDs. Especially, we adopted the phenyl linker unit as a core moiety for these two fluoranthene and benzoquinoline moieties. As a result, we could increase the thermal stability as well as electron transporting behavior as compared to those of TPBI.²³ The detailed synthetic route for the preparation of these materials is shown in Scheme 1.

Fig. 1(a) and (b) show the molecular geometry of the ground state (S_0) of TPBI and **FRT-PBQ**, which were obtained from the molecular simulation using the Gaussian 09 software. The HOMO and lowest unoccupied molecular orbital (LUMO) were optimized using Becke's three-parameter method and the Lee–Yang–Parr correlation (B3LYP) functional with the 6-31G (d) basis set. From this result, we found that the HOMO was mostly distributed over the entire molecule, whereas the LUMO was mostly localized on the fluoranthene and benzene core moieties, as shown in Fig. 1(b). This means that the electron transport process through the **FRT-PBQ** molecule may occur at the fluoranthene moiety although the benzoquinoline moiety has an electron-withdrawing heteroaromatic component. Moreover, the twisted angle of **FRT-PBQ** (between the fluoranthene moiety



Scheme 1 Synthesis of the new electron transport material.

and the central phenyl linker) is about 53.8° . It was larger than that (about 34.0°) of TPBI (between the benzimidazole moiety and the central phenyl linker), which may cause interruption of the π – π stacking. However, we could not expect that those twisted angles can interrupt to reduce the electron mobility because the planar fused aromatic systems such as fluoranthene and benzoquinoline moieties are large enough to be separated from the central core unit (*e.g.*, phenyl linker). Moreover, these bulky and planar moieties could increase the thermal stability, as abovementioned. We also calculated the excited state of the **FRT-PBQ** molecule using the same theory (TD-DFT, B3LYP/6-311++G(d)) and obtained a triplet energy level (T_1) of 2.30 eV, which is also summarized in Table 1.

Fig. 2(a) displays the UV-vis absorption and PL spectra of **FRT-PBQ**. The band gap E_g that was determined from the band edge of the UV-vis spectrum was 3.09 eV for **FRT-PBQ**. The HOMO energy level measured by the AC2 analyzer and the LUMO energy level determined *via* the subtraction of the band

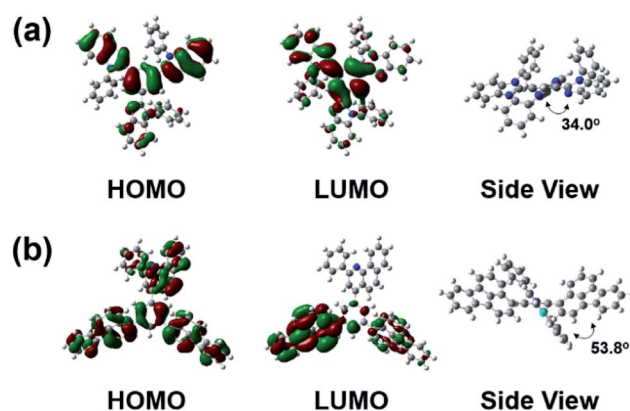


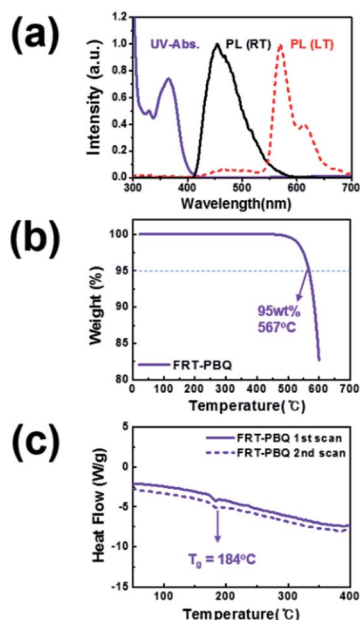
Fig. 1 Optimized molecular geometry of (a) TPBI and (b) **FRT-PBQ** molecule showing HOMO (left), LUMO (middle), and side-view of the molecule (right).



Table 1 A summary of the physical properties of the electron transport material

Compound	λ_{abs}^a [nm]	λ_{pl}^b [nm]		T_1 [eV] (exp)	T_1^c [eV] (cal)	HOMO [eV] (AC2)	LUMO [eV]	E_g [eV]	T_g [°C]	T_m [°C]	T_d [°C]
		297 K	77 K								
FRT-PBQ	246, 269, 290, 365	455	569	2.18	2.30	−5.99	−2.90	3.09	184	—	567

^a λ_{abs} : peak wavelength observed *via* UV-visible absorption spectroscopy (at 297 K). ^b λ_{pl} : peak wavelength measured from the photoluminescence (PL) spectra (at 297 K and 77 K). ^c T_1 was calculated using the Gaussian 09W program [B3LYP, 6-311++G].

**Fig. 2** (a) UV-visible absorption and photoluminescence spectra, (b) TGA, and (c) DSC results of **FRT-PBQ**.

gap from the HOMO energy level were −5.99 and −2.90 eV, respectively. Moreover, **FRT-PBQ** exhibited featureless emission spectral patterns, whereas some vibronic fine emission peaks were observed in the emission spectra obtained under low-temperature condition (77 K). From this spectrum, we confirmed the T_1 of 2.18 eV for **FRT-PBQ**. In addition, we investigated the thermal stability behavior of **FRT-PBQ**, as shown in Fig. 2(b) and (c). As a result, the decomposition temperature T_d and T_g were determined to be 567 and 184 °C for **FRT-PBQ**, respectively. As was expected, **FRT-PBQ** possesses much higher T_g of 184 °C as compared to those of common ETMs [*e.g.*, T_g (TPBI) = 124 °C; T_g (TmPyPB) = 79 °C; and T_g (BPhen) = 66 °C], which might be due to its rigid structure.²⁴ All the abovementioned data are also summarized in Table 1.

Device engineering for highly efficiency OLEDs

Design of electron only device. To investigate the electron transport behavior, we prepared electron only devices (EODs) with **FRT-PBQ** that have the following device configurations (see also Fig. 3(a)). We also investigated a reference device with the common ETL material (TPBI) as a bulk state.

EOD A: ITO/LiQ (1.5 nm)/TPBI (100 nm)/LiF (1.0 nm)/Al (100 nm).

EOD B: ITO/LiQ (1.5 nm)/**FRT-PBQ** (100 nm)/LiF (1.0 nm)/Al (100 nm).

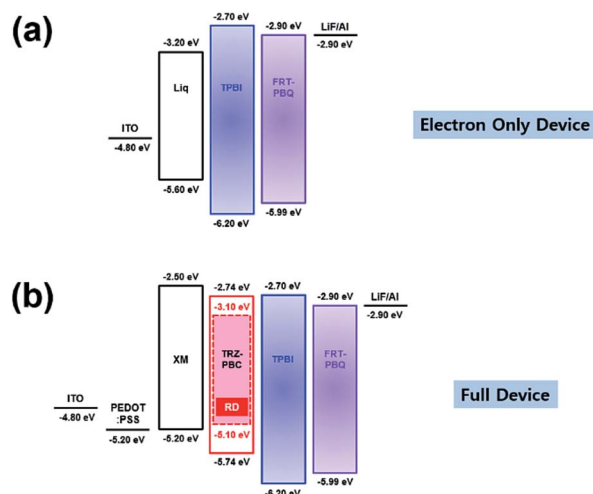
Fig. 3(a) shows the energy band diagram of the EODs of the ETMs. These materials exhibit LUMO energy levels of −2.70 and −2.90 eV for TPBI and **FRT-PBQ**, respectively. For this reason, we expected that **FRT-PBQ** might show better electron injection behavior than TPBI. However, we observed lower electron density from the EOD B (prepared with **FRT-PBQ**) as compared to that from the EOD A (with TPBI) at the voltage range less than 1.5 V. Hence, we cannot conclusively say that **FRT-PBQ** has better electron injection property than TPBI. In other words, the electron mobility of TPBI seems to be greater than that of **FRT-PBQ** at low electric field. Actually, we calculated the electron mobility of **FRT-PBQ** and TPBI from the space-charge-limited current (SCLC) region as follows in the next equation (eqn (1)):²⁵

$$J = \frac{9}{8} \epsilon_r \epsilon_0 \mu \frac{V^2}{L^3} \quad (1)$$

and

$$\mu = \mu_0 \exp\left(\beta \sqrt{\frac{V}{L}}\right), \quad (2)$$

where ϵ_r is the relative permittivity (~ 3), ϵ_0 is the vacuum permittivity ($\sim 8.85 \times 10^{-14}$ F cm^{−1}), μ is the carrier mobility determined *via* SCLC measurements, L is the cathode–anode

**Fig. 3** Energy band diagram of the fabricated (a) electron only devices and (b) red PHOLEDs.

distance, μ_0 is the zero-field mobility, and β is a coefficient that is proportional to the Poole-Frenkel factor. μ_0 and β were determined *via* linear fitting. From eqn (1) and (2), we obtained the electron mobility, as shown in Fig. 4(b).

As a result, the calculated electron mobilities are 1.70×10^{-5} and $1.66 \times 10^{-6} \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$ for TPBI and **FRT-PBQ**, respectively, revealing the much lower electron mobility of **FRT-PBQ** than that of TPBI under low electric field. The electron mobility of **FRT-PBQ** is a reliable value because the TPBI mobility matches quite well with the previously reported value.²⁶ From the results, it was observed that **FRT-PBQ** provided lower electron mobility than TPBI due to the increased twisted angle. However, the electron current density of **FRT-PBQ** rapidly increased in the higher voltage regions as aforementioned ($>1.5 \text{ V}$) [see also Fig. 4(a)]. This type of reversal phenomenon in electron current density might be originated from the intrinsic molecular structure of **FRT-PBQ**. In other words, the weak electron accepting ability of **FRT-PBQ** presumably due to its lower polarity characteristic (1.5814 D) as compared to that of TPBI (2.4206 D) may cause relatively poorer electron injection behavior, whereas the flat and planar fluoranthene moieties help to efficiently transport the electron carriers at higher electric field region.²⁷

Solution-processed OLEDs with a new ETM. To verify the **FRT-PBQ** characteristics, we prepared the solution-processed red PHOLEDs with the following device configurations (Fig. 3(b)). We also fabricated reference devices with TPBI to compare the performance levels.

Device A: ITO/PEDOT:PSS (40 nm)/XM (17 nm)/RH:RD (5%, 30 nm)/TPBI (50 nm)/LiF (1 nm)/Al (100 nm).

Device B: ITO/PEDOT:PSS (40 nm)/XM (17 nm)/RH:RD (5%, 30 nm)/**FRT-PBQ** (50 nm)/LiF (1 nm)/Al (100 nm).

The red PHOLEDs with TPBI and **FRT-PBQ** exhibited different device characteristics depending on the ETM, as shown in Fig. 5. Fig. 5(a) shows the current-density-voltage-

luminance (J - V - L) characteristics. At a given constant voltage of 5.0 V ($>1.5 \text{ V}$, as aforementioned), the current density values were found to be 0.16 and 1.57 mA cm^{-2} for device A and B, respectively. This is well consistent with the results obtained from the EODs. In other words, the higher current transporting behavior of **FRT-PBQ** makes device B much more electron conductive. For this reason, the turn-on voltages (V_{on}) at a given constant luminance of 1 cd m^{-2} were 3.8 and 3.0 V for device A and B, respectively.

In addition, the operation voltages (V_{op}) required to achieve 1000 cd m^{-2} were 6.7 and 6.0 V for device A and B, respectively (see Table 2). At a given constant luminance of 1000 cd m^{-2} , the current and power efficiencies were 15.4 cd A^{-1} and 7.1 lm W^{-1} and 18.6 cd A^{-1} and 9.3 lm W^{-1} for device A and B, respectively, as shown in Fig. 5(b) and Table 2. In addition, this efficiency data correspond to the external quantum efficiencies (EQEs) of 11.1 and 13.0% for device A and B, respectively, as shown in the inset of Fig. 5(b). The maximum current and power efficiencies were 15.5 cd A^{-1} and 11.4 lm W^{-1} for device A and 20.7 cd A^{-1} and 21.7 lm W^{-1} for device B, respectively, as summarized in Table 2. In particular, the maximum EQE value of device A increased more than that of device B (*i.e.*, device A: 11.4%; device B: 15.5%). From the abovementioned results, we found that the predominant electron transport characteristics were necessary because the devices fabricated with cross-linkable HTL materials *via* the solution process normally exhibited pretty low hole conductivity behavior. As a result, device B with higher electron transporting materials showed higher efficiency values although it displayed more serious roll-off behavior as compared to device A, plausibly due to its narrower recombination zone originating from its higher electron transporting property.

Moreover, we investigated the EL spectral response, as shown in Fig. 5(c). From this measurement, we found that all

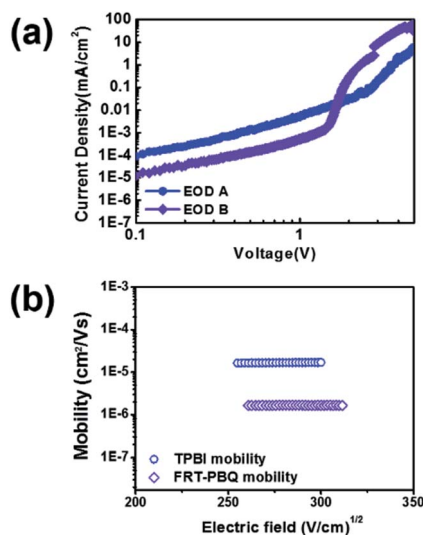


Fig. 4 (a) J - V characteristics of the electron only devices with EOD A and EOD B and (b) calculated electron mobility for TPBI and **FRT-PBQ** from the SCLC region.

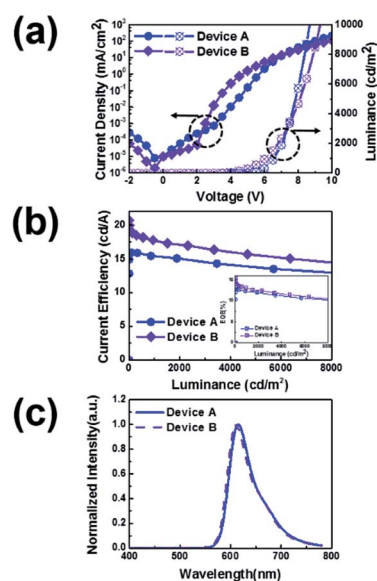


Fig. 5 (a) J - V - L , (b) current-efficiency- L -power efficiency, and (c) normalized EL spectra of the fabricated red PHOLEDs (at brightness of 1000 cd m^{-2}).



Table 2 Summary of the device characteristics of the solution-processed red PHOLEDs

Device	V_{on}^a/V_{op}^b [V]	CE/PE/EQE [cd A ⁻¹ /lm W ⁻¹ /%]		CIE (x, y) ^{bc}	Lifetime ^b (hours)
		Maximum	At 1000 cd m ⁻²		
Device A	3.8/6.7	15.5/11.4/11.4	15.4/7.1/11.1	(0.65, 0.35)	180.0
Device B	3.0/6.0	20.7/21.7/15.5	18.6/9.3/13.0	(0.65, 0.35)	301.4

^a Measured at 1 cd m⁻². ^b Measured at 1000 cd m⁻². ^c CIE: Commission International de L'Eclairage.

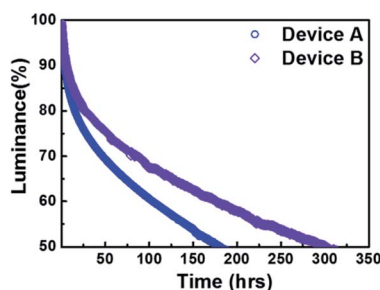


Fig. 6 Operational lifetime of device A and device B (with an initial brightness of 1000 cd m⁻²).

the normalized EL spectra obtained from device A and B at a brightness of 1000 cd m⁻² were almost the same, showing a maximum EL peak wavelength (λ_{max}) of 611 nm.

Finally, we measured the operational lifetimes of device A and B, as shown in Fig. 6. The lifetimes were measured under constant current density condition, giving rise to an initial brightness of 1000 cd m⁻². The lifetimes at 50% drop of the initial brightness (T_{50}) of device A and B were 180.0 and 301.4 h, respectively. Very interestingly, device B exhibited a much better lifetime behavior, which was 1.7 times higher than that of device A. This could be due to improved device efficiency as well as a reduction in the probability of crystallization and/or aggregation of the ETM during device operation, as abovementioned.

Based on these results, we believe that **FRT-PBQ** could provide fairly good device performances, including increased operational lifetime, because of its suitable electron transporting behavior as well as thermal stability when it is applied to solution-processed PHOLEDs.

Conclusions

In this study, we prepared a new ETM with a high glass transition temperature and superior electron transport behavior using two fluoranthene and one benzoquinoline-based moieties connected to a core phenyl linker unit. As a result, **FRT-PBQ** showed very good device performances when it was applied to solution-processed red PHOLEDs. Especially, the solution-processed red PHOLED devices fabricated in this study exhibited outstanding device efficiency as well as dramatically improved lifetime (by about 167.4%) as compared to those fabricated with common ETM such as TPBI.

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